TOSHIBA Diode Silicon Epitaxial Planar Type

1SS200

Ultra High Speed Switching Application

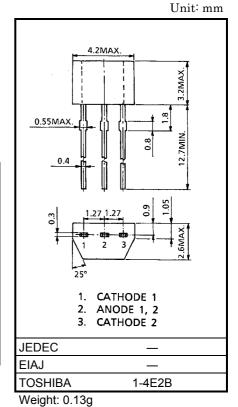
- Low forward voltage $V_{\rm F}$ (3) = 0.92V (typ.)
- Fast reverse recovery time: $t_{rr} = 1.6ns$ (typ.) •
- Small total capacitance $: C_T = 2.2 pF (typ.)$ •

Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Maximum (peak) reverse voltage	V _{RM}	85	V
Reverse voltage	V _R	80	V
Maximum (peak) forward current	I _{FM}	300 (*)	mA
Average forward current	Ι _Ο	100 (*)	mA
Surge current (10ms)	I _{FSM}	2 (*)	А
Power dissipation	Р	200	mW
Junction temperature	Tj	125	°C
Storage temperature range	T _{stg}	-55~125	°C

(*) Unit Rating. Total Rating = Unit Rating × 1.5.

Electrical Characteristics (Ta = 25°C)



Test Condition	Min	Тур.

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit	
Forward voltage	V _{F (1)}	_	I _F = 1mA	_	0.61	—		
	V _{F (2)}	_	I _F = 10mA	_	0.74	—	V	
	V _{F (3)}	_	I _F = 100mA	_	0.92	1.20		
Reverse current	I _{R (1)}	_	V _R = 30V	_	—	0.1		
	I _{R (2)}	_	V _R = 80V	_	—	0.5	μA	
Total capacitance	CT	_	V _R = 0, f = 1MHz	_	2.2	4.0	pF	
Reverse recovery time	t _{rr}	_	I _F = 10mA (Fig.1)		1.6	4.0	ns	

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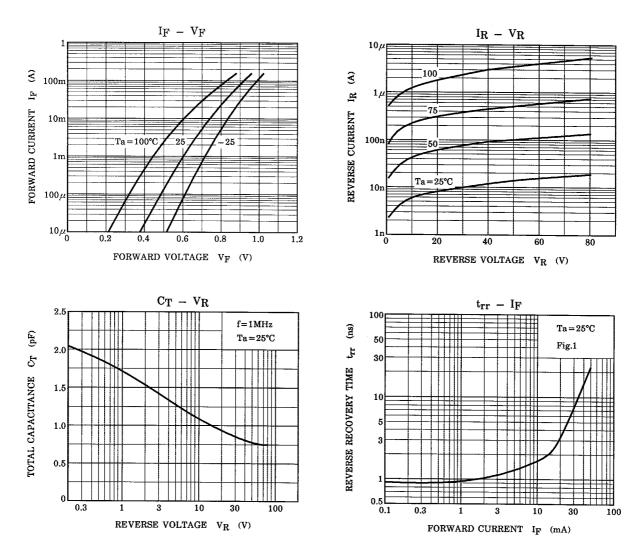
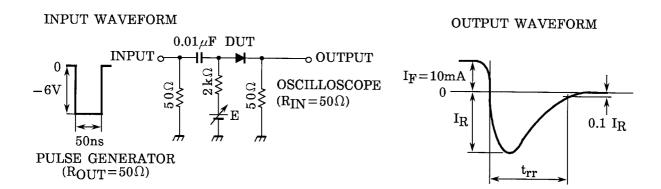


Fig.1 Reverse recovery time (trr) test circuit



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